



iWoRiD 2022

23rd International Workshop on Radiation Imaging Detectors

26 – 30 June 2022

Riva del Garda, Italy

Contribution ID: 105

Type: **Oral**

Performance studies of Low Gain Avalanche Detectors (LGAD) coupled to the Timepix3 ASIC

Thursday 30 June 2022 10:15 (20 minutes)

In this work the properties of 200 μm thick highly pixelated LGAD sensors bonded to a Timepix3 readout ASIC were characterised for the first time. Recent advances in the control of the LGAD fabrication process by Micron Semiconductor Ltd has allowed the manufacture of highly segmented devices where each pixel has an internal gain. Devices with 55 μm pixel with 5 μm Junction Termination Element (JTE), 110 μm pixel with 10 μm JTE and 110 μm pixel with 20 μm JTE were bump bonded to a Timepix3 readout ASIC and characterised with a micro-focus monochromatic 15 keV X-ray beam.

Figure 1 shows the response profile from the 110 μm pixel device from the X-ray beam as the pixel array was moved relative to the beam for the pixel of interest (PoI), and its neighboring pixels (left-hand side and right-hand side pixels). The quantity plotted is the integrated time-over-threshold (ToT) for the pixel from an illumination of 5 seconds per illumination position. This corresponds to the total collected charge at the pixel electrode. The PoI boundaries can be seen between motor positions -17.55 and 17.44 mm. A region of gain in the middle of each pixel can clearly be observed. The gain of factor approximately three can be extracted directly from the pixel profile. Figure 2 shows a 2D map obtained by a raster scan of the pixel array recording the integrated ToT from the PoI. The regions of gain and no gain are clearly visualized. Results obtained suggest a good degree of understanding of the fabrication processes involved but demonstrated the limitations of the standard LGAD process with a JTE for small pixel. This work will report on the characterisation of fabricated devices and suggest mechanisms for mitigating the effects of limited gain regions for small sized pixel.

Primary author: Dr MANEUSKI, Dima (University of Glasgow (GB))

Co-authors: BATES, Richard (University of Glasgow (GB)); BULLOUGH, Mark (Micron Semiconductor Limited); EKLUND, Lars (Uppsala University (SE)); LOMBIGIT, Lojius; MOFFAT, Niel (Centro Nacional de Microelectronica); TARTONI, Nicola

Presenter: Dr MANEUSKI, Dima (University of Glasgow (GB))

Session Classification: Applications